

Notice of References Cited	Application/Control No. 10/064,252	Applicant(s)/Patent Under Reexamination YEH, CHIEN-LIANG	
	Examiner Cheukfan Lee	Art Unit 2625	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,481,626	11-2002	Nahar, Rathindra	235/462.14
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
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	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
	O					
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NON-PATENT DOCUMENTS

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